

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination KITAMURA ET AL.	
			Examiner MICHAEL M. BERNSTEYN	Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,248,469	06-2001	Formato et al.	429/41
*	B	US-2002/0076594	06-2002	Fukuda et al.	429/30
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 9910165 A1	03-1999	World Intellect	FORMATO et al.	
*	O	WO 200225764 A1	03-2002	World Intellect	HICKNER et al.	
*	P	JP 2002203576 A	07-2002	Japan	SUZUKI et al.	
	Q	JP 2000256486 A	09-2000	Japan	SAKUMA et al.	
	P					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.